

TEST REPORT

Electromagnetic compatibility (EMC)

Generic standards for residential and industrial environments

Report Reference No	429784-2TF	RFEMC				
Tested by (name, function and signature):	D. Teruzzi	(project handler)				
Approved by (name, function and signature):	P. Barbieri (verifier) Bault					
Date of issue:	2021-04-01					
Testing Laboratory	Nemko Spa	a				
Address:	Via del Carı	roccio, 4 – 20853 Biassono (MB) – Italy				
Testing location	Nemko Spa	a				
Address	Via del Carı	roccio, 4 – 20853 Biassono (MB) – Italy				
Applicant's name	Nextys SA					
Address	Via Luserte	Sud, 6 – 6572 Quartino – Switzerland				
Test specification:						
Standard:	EN 55011:2016 + A11:2020 - EN 61000-6-2:2019 EN 61000-6-3:2007 + A1:2011 + AC:2012 EN 61000-3-2:2019 - EN 61000-3-3:2013 + A1:2019 : EN 61000-4-2:2009 - EN 61000-4-3:2006 + A1:2008 + A2:2010 EN 61000-4-4:2012 - EN 61000-4-3:2014 + A1:2017 EN 61000-4-6:2014 / AC:2015 - EN 61000-4-8:2010 EN 61000-4-11:2020 - EN61000-4-34:2007 + A1:2009					
	Full application of the standards					
	Partial application of the standards					
Test procedure	Nemko WM	I L0077, WM L0177 and WM L1002				
Test Report Form No	61000-6-XT	RFEMC				
TRF Originator:	Nemko Spa	l l				
Master TRF	2014-06					
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Test item description : DIN rail power supply						
Trade Mark	.: TDK-Lambda					
Manufacturer:	: Nextys SA					
Address of manufacturer:	: Via Luserte Sud, 6 – 6572 Quartino – Switzerland					
Model:	.: DRB120-24-3-A0					
Ratings	Input: 3~ 400-500V / 50-60 Hz / 3x0.5A Output: 22.5 – 29 VDC – 120 W nominal					

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Test Benort No · 429784.	2TREEMC	2021-04-01
		Date of issue
Short description of the EuT	Со	py of marking plate
The EUT is a DIN rail power supply	TDK-Lambdo Image: A standard of all and the standard of all	DRB120-24-3-A0 Ind stored DiR rail power supply we parts In Yeal power supply 3-400-500V / 50-60Hz / 3x0 5A OUTPUT Mominali 140V / 22 5-29V = / 5.3.4 1A Maximum 146W / 22 5-29V = / 5.3.4 1A Maximum 146W / 22 5-29V = / 5.3.4 1A Maximum 146W / 22 5-29V = / 5.3.4 1A Maximum 146W / 22 5-29V = / 5.3.4 1A Maximum 146W / 22 5-29V = / 5.3.4 1A Maximum 146W / 22 5-29V = / 5.3.4 1A Maximum 146W / 22 5-29V = / 5.3.4 1A Maximum 146W / 22 5-29V = / 6.44 9A / max 24ec Operating temperature -25.70°C (/ 13. 158)*F) denating from 55°C (131*F) Successor product of . Successor product of . Designed in Switzerland Made in Malaysia
Number of tested samples	1 4297840003 (numl < 108 MHz Residential and ind Rack Mounting The E.U.T. is comp //	ber assigned by Nemko Spa) Iustrial locations posed of a single unit
Testing Date of receipt of test sample Testing commenced on Testing concluded on Preside test sample	2021-03-01 2021-03-01 2021-03-31	
Possible test case verdicts: test case does not apply to the test object	N (Not applicable) NP (Not Performed P (Pass) F (Fail)	d)
The crossed square indicates that the listed condition The empty square indicates that the listed condition Throughout this report point is used as decimal separative The results contained in this report reflect the result responsibility of the manufacturer to ensure that all detailed within this report.	dition or equipment tion or equipment is arator. Its for this particular production models	is applicable for this report. not applicable for this report. r model and serial number. It is the meet the intent of the requirements

Verdict according to the standards on page 5:



PROJECT HISTORY						
Report number	Modification to the report / comments	Date				
429784-2TRFEMC	First release	2021-04-01				
REMARKS						

PRODUCT VARIANTS								
Variant model	Difference against the main model	Additional test performed						
REMARKS								



Contents

<u>1</u>	TEST STANDARDS	5
2	SUMMARY OF TEST RESULTS	7
-		
<u>3</u>	EQUIPMENT UNDER TEST	8
3.1	POWER SUPPLY SYSTEM UTILISED	8
3.2	EUT OPERATION MODES	8
3.3	EUT CONFIGURATION MODES	8
3.4	INPUT/OUTPUT PORTS	9
3.5	Equipment Used During Test	9
3.6	PERFORMANCE LEVEL	10
<u>4</u>	TEST LABORATORY CONDITIONS	11
4.1	ADDRESS OF THE TEST LABORATORY	11
4.2	ENVIRONMENTAL CONDITIONS	11
4.3	MEASUREMENT UNCERTAINTY AND ASSESSMENT OF CONFORMITY	11
<u>5</u>	TEST CONDITIONS AND RESULTS	13
5.1	RADIATED DISTURBANCE IN THE FREQUENCY RANGE 30 MHZ TO 1 000 MHZ	13
5.2	TERMINAL DISTURBANCE VOLTAGES IN THE FREQUENCY RANGE 150 KHZ TO 30 MHZ	17
5.3	HARMONICS OF CURRENT	22
5.4	VOLTAGE CHANGES, VOLTAGE FLUCTUATIONS AND FLICKER	27
5.5	IMMUNITY TO POWER-FREQUENCY MAGNETIC FIELDS	29
5.6	IMMUNITY TO RADIO FREQUENCY ELECTROMAGNETIC FIELDS	31
5.7	IMMUNITY TO ELECTROSTATIC DISCHARGES	33
5.8	IMMUNITY TO INJECTED CURRENTS UP TO 80 MHz	35
5.9	IMMUNITY TO FAST TRANSIENTS/BURSTS	37
5.10	IMMUNITY TO SURGES	39
5.11	IMMUNITY TO VOLTAGE DIPS AND INTERRUPTIONS	42
<u>6</u>	EUT PHOTOS	44



1 TEST STANDARDS

The tests were performed according to following standards and procedures.

NEMKO WM L0177: General routines for using instruments at Nemko

NEMKO WM L1002: Measurement Uncertainty - Policy and Statement

NEMKO WM L0077: General routines to perform EMC tests

EN 55011:2016 + A11:2020

Industrial, scientific and medical equipment - Radio-frequency disturbance characteristics - Limits and methods of measurement

EN 61000-6-2:2019

Electromagnetic compatibility (EMC) -- Part 6-2: Generic standards - Immunity for industrial environments

EN 61000-6-3:2007 + A1:2011 / AC:2012

Electromagnetic compatibility (EMC) -- Part 6-3: Generic standards - Emission standard for residential, commercial and light-industrial environments

EN 61000-3-2:2019

Electromagnetic compatibility (EMC) -- Part 3-2: Limits - Limits for harmonic current emissions (equipment input current <= 16 A per phase)

EN 61000-3-3:2013 + A1:2019

Electromagnetic compatibility (EMC) - Part 3-3: Limits - Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current <= 16 A per phase and not subject to conditional connection

EN 61000-4-2:2009

Electromagnetic compatibility (EMC) -- Part 4-2: Testing and measurement techniques - Electrostatic discharge immunity test

EN 61000-4-3:2006 + A1:2008 + A2:2010

Electromagnetic compatibility (EMC) -- Part 4-3: Testing and measurement techniques - Radiated, radiofrequency, electromagnetic field immunity test

EN 61000-4-4:2012

Electromagnetic compatibility (EMC) -- Part 4-4: Testing and measurement techniques - Electrical fast transient/burst immunity test

EN 61000-4-5:2014 + A1:2017

Electromagnetic compatibility (EMC) -- Part 4-5: Testing and measurement techniques - Surge immunity test

EN 61000-4-6:2014 / AC:2015

Electromagnetic compatibility (EMC) -- Part 4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields



EN 61000-4-8:2010

Electromagnetic compatibility (EMC) -- Part 4-8: Testing and measurement techniques - Power frequency magnetic field immunity test

EN 61000-4-11:2020

Electromagnetic compatibility (EMC) -- Part 4-11: Testing and measurement techniques - Voltage dips, short interruptions and voltage variations immunity tests

EN 61000-4-34:2007 + A1:2009

Electromagnetic compatibility (EMC) - Part 4-34: Testing and measurement techniques - Voltage dips, short interruptions and voltage variations immunity tests for equipment with mains current more than 16 A per phase



2 SUMMARY OF TEST RESULTS

EN 55011 / EN 61000-6-3 / EN 61000-3-2 / EN 61000-3-3					
Requirement – Test	Frequency range	Verdict			
Enclosure port – Radiated disturbance	30 MHz to 1 000 MHz	Р			
AC mains port – Terminal disturbance voltages	150 kHz to 30 MHz	Р			
AC mains port – Discontinuous disturbance	150 kHz to 30 MHz	NP ¹			
AC mains port – Harmonic current emissions	0 kHz – 2 kHz	Р			
AC mains port – Voltage changes, voltage fluctuations and flicker	50 Hz	Р			
DC power port –Terminal disturbance voltages	150 kHz to 30 MHz	N ²			
Telecommunications port - Terminal disturbance voltages	150 kHz to 30 MHz	Ν			

Immunity tests						
Requirement - Test	Ref standard	Verdict				
Enclosure port – Electrostatic discharges	EN 61000-4-2	Р				
Enclosure port – Radio-frequency electromagnetic field	EN 61000-4-3	Р				
I/O AC power ports – Fast transients	EN 61000-4-4	Р				
I/O DC power ports – Fast transients	EN 61000-4-4	P ¹				
Signal ports – Fast transients	EN 61000-4-4	P ¹				
I/O AC power ports – Surges	EN 61000-4-5	Р				
I/O DC power ports – Surges	EN 61000-4-5	Р				
Signal ports – Surges	EN 61000-4-5	Ν				
I/O AC power ports – Radio-frequency common mode	EN 61000-4-6	Р				
I/O DC power ports – Radio-frequency common mode	EN 61000-4-6	Ν				
Signal ports – Radio-frequency common mode	EN 61000-4-6	Ν				
Enclosure port – Power-frequency magnetic field	EN 61000-4-8	Р				
Input AC power ports – Voltage dips	EN 61000-4-11 EN 61000-4-34	Р				
Input AC power ports – Voltage interruptions	EN 61000-4-11 EN 61000-4-34	Р				

GENERAL REMARKS

¹ according to applicant's request

² Applicable only to ports intended for connection to: - a local DC power network, or

- a local battery by a connecting cable exceeding a length of 30 m



<u>3 EQUIPMENT UNDER TEST</u>

3.1 Power supply system utilised

Power supply voltage:		230 V/50 Hz / 1φ	115 V/60 Hz / 1φ
	\boxtimes	400 V/50 Hz 3PE	400 V/50 Hz 3NPE
		12 V DC	24 V DC

3.2 EuT operation modes

Mode	Description
1	The EUT has been tested connected to an adequate load to obtain maximum output power

3.3 EuT Configuration modes

Emission: the EuT was configured to measure its highest possible radiation level. The test modes selected are according to EuT instruction manual.

Immunity: the EuT was configured to have its highest possible susceptibility against tested phenomena. The test modes selected are according to EuT instruction manual.

Mode	Description
1	The EUT has been tested connected to the mains, the DC output is connected to a resistive load and only for fast transient tests, the signal cable has been connected to a multimeter.



3.4 Input/Output Ports

Dout	Nomo	Tupo*	Cable	Cable	Description
Port	Name	Max. >3m Shielded	Description		
0	Enclosure	N/E	—	_	
1	Mains	AC			3 PE cable
2	Output	DC			Two wires cable
3	DC-OK signal	I/O			Two wires
*Note	:				
	AC = AC Power Port	DC = DC Power Port N/E = Non-Electrical			
	I/O = Signal/Control Input or Output Port				TP = Telecommunication Ports

3.5 Equipment Used During Test

Use*	Product Type	Manufacturer	Model	Comments			
AE	Load	Nextys	//	Supplied by customer			
AE	Current clamp	Beha Amprobe	AMP-25-EUR	Supplied by customer			
AE	E Multimeter FLUKE 867 Supplied by Nemko Spa						
Note: * Use							
EUT - Equipment Under Test							
AE - Auxiliary/Associated Equipment (Not Subjected to Test)							
SIM - Simulator (Not Subjected to Test)							



3.6 Performance level

The test results shall be classified in terms of the loss of function or degradation of performance of the equipment under test, relative to a performance level defined by its manufacturer or the requestor of the test, or agreed between the manufacturer and the purchaser of the product.

Definition related to the performance level:

	based on the used product standard	
\boxtimes	based on the declaration of the manufacturer, requestor or purchaser	

Criterion A:

Definition: The apparatus shall continue to operate as intended during and after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance.

Representative parameter	Acceptable level of performance	
Output current	±10 % of nominal value	
Output Voltage	±10 % of nominal value	

Criterion B:

Definition: The apparatus shall continue to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed. No change of actual operating state or stored data is allowed.

Representative parameter	Acceptable level of performance	
Output current	±10 % of nominal value	
Output Voltage	±10 % of nominal value	

Criterion C:

Definition: Temporary loss of function is allowed, provided the function is self-recoverable or can be restored by the operation of the controls.



4 TEST LABORATORY CONDITIONS

4.1 Address of the test laboratory

Nemko Spa Via del Carroccio, 4 20853 Biassono (MB) - Italy

4.2 Environmental conditions

In the laboratory, the following ambient conditions are respected for each test reported below:

Ambient temperature:	18 ÷ 33 °C (1)
Relative Humidity:	25 ÷ 70 % ⁽²⁾
Atmospheric pressure:	860 ÷ 1060 hPa

 $^{(1)}$ For luminaire, temperature during tests was verified to be within 18 \div 30 °C $^{(2)}$ During ESD test, humidity was verified to be within 30 \div 60 %

The following instruments are used to monitor the environmental conditions:

Equipment	Manufacturer	Model	Serial N°
Thermo-hygrometer data loggers	Testo	175-H2	20012380/305
Thermo-hygrometer data loggers	Testo	175-H2	38203337/703
Barometer	Castle	GPB 3300	072015

4.3 Measurement uncertainty and assessment of conformity

The measurement uncertainty was calculated for each test and quantity listed in this test report, according to CISPR 16-4-2 and other specific test standard and is documented in Nemko Spa working manual WML1002.

The assessment of conformity for each test performed on the equipment is performed not taking into account the measurement uncertainty. The two following possible verdicts are stated in the report:

P (Pass) - The measured values of the equipment respect the specification limit at the points tested. The specific risk of false accept is up to 50% when the measured result is close to the limit.

F (Fail) - One or more measured values of the equipment do not respect the specification limit at the points tested. The specific risk of false reject is up to 50% when the measured result is close to the limit.

Hereafter Nemko's measurement uncertainties are reported:



Test	Range	Measurement Uncertainty	Notes
	Antenna distance 3 m, 10 m 0.009 ÷ 200 MHz	5.0 dB	(1)
	Antenna distance 1 m, 3 m, 10 m 200 ÷ 1000 MHz	5.2 dB	(1)
Radiated Disturbance 10m Chamber	Antenna distance 1 m, 3 m, 10 m 1 ÷ 6 GHz	5.2 dB	(1)
	Antenna distance 1 m, 3 m 6 ÷ 18 GHz	5.5 dB	(1)
	Antenna distance 1 m, 3 m 18 ÷ 40 GHz	7.2 dB	(1)
Radiated Disturbance with large loop antenna system (LLAS)	0.009 ÷ 30 MHz	3.3 dB	(1)
Orachistad Distudy and	0.02 ÷ 150 kHz with AMN 150 kHz ÷ 30 MHz with AMN	3.8 dB 3.4 dB	(1) (1)
Conducted Disturbance	9 kHz ÷ 30 MHz with voltage probe	4.6 dB 2.9 dB	(1)
	9 ÷ 150 kHz	2.9 dB 3.8 dB	(1)
Clicks	150 kHz ÷ 30 MHz	3.4 dB	(1)
Disturbance Power	30 MHz ÷300 MHz	4.5 dB	(1)
Frequency	10 Hz ÷ 1 kHz	0.2 %	(1)
	1 kHz ÷ 40 GHz	10**	(1)
Harmonic Current Emission	50 HZ ÷ 2 KHZ	3%	(1)
Fluctuation and Flickers	Flickers	5 %	(1)
Radiated Immunity	20 MHz ÷ 6 GHz	3.4 dB	(1) (3)
Rediated Immunity TEM Coll	0.01 · 200 MHz	3 0 dB	(1) (3)
Bulk Current	1 ÷ 200 MHz	3.0 dB	(1)(3)
Immunity to conducted disturbances	9 kHz ÷ 230 MHz	3.0 dB	(1)
ESD Immunity	Voltage, Current, Rise time, Duration	(2)	(1)
Burst Immunity	Voltage, frequency, burst period and duration, rise time and pulse width	(2)	(1)
Surge Immunity	Voltage, Current, Rise time, Duration	(2)	(1)
DIPS, Interruption and Voltage duration	Amplitude	5 %	(4)
Immunity	Duration	5 %	(1)
Impulse Magnetic Field Immunity	Peak Current	10 %	(1) (3)
	Rise time, Duration	20 %	(1)(0)
Power Frequency Magnetic Field Immunity	16.7 Hz, 50 Hz, 60 Hz	2.0 dB	(1) (3)
Damped Oscillatory Wave Immunity Ring Wave Immunity	Voltage, front time, frequency 100 kHz, 1 MHz	(2)	(1)
Dampod Magnotic Field	Amplitude: 100 kHz, 1 MHz	3 dB	(1)
Damped Magnetic Field	Frequency: 100 kHz, 1 MHz	10 %	(1)
Low Frequency Immunity	15 Hz ÷ 150 kHz	2.2 dB	(1)
Automotive transients Immunity	Voltage, rise time, duration time Impulses 1, 2a, 2b, 3a, 3b and 4	(2)	(1)
Automotive transients Emission	Amplitude, Time	10 %	(1)
EMF for Lighting Equipment	-	25 %	(1)
Electromagnetic fields (EMF)	Magnetic, Electric and Electromagnetic fields: 0 Hz ÷ 40 GHz	25 %	(1)
Electrical quantities (voltage, current, resistance)	AC/DC Voltage 10 mV ÷ 1000 V 0÷100 kHz AC/DC Current 0.1 mA ÷ 400 A 0÷1 kHz Resistance 100 mΩ ÷ 10 MΩ	2.5 %	(1)
NOIES:			lass dia a
(1) The reported expanded uncertainty of r coverage factor $k = 2$ which for a normal dis	neasurement is stated as the standard uncertainty of me stribution corresponds to a coverage probability of approxi-	easurement multiplied	by the

(2) The instruments used for this immunity test is according to the tolerances requested by the applicable standard (3) The reported expanded uncertainty of measurement is related to the stimulus quantity



5 TEST CONDITIONS AND RESULTS

5.1 Radiated disturbance in the frequency range 30 MHz to 1 000 MHz

5.1.1 Photo documentation of the test set-up



5.1.2 Test method

Measurements were made on a semi anechoic chamber. Preliminary measurements were performed at an antenna to EUT separation distance of 10 meters and 3 meters with the receive antenna located at a fixed height (from 1 to 4 meter) in both horizontal and vertical polarities. Final measurements were then performed by rotating the EUT 360° and adjusting the receive antenna height from 1 to 4 meters. All frequencies were investigated in both horizontal and vertical antenna polarity, where applicable.

5.1.3 Limits for enclosure

Frequency (MHz)	Limit (dBµV/m) – Quasi-Peak
30 TO 230	30
230 TO 1 000	37



5.1.4 Test result

Verdict:	
Frequency range:	30 MHz – 1 000 MHz
Kind of test site:	Semi anechoic chamber
Measurement distance:	10 m
Remarks:	

5.1.5 Test equipment used

Description	Manufacturer	Model	Identifier
Controller for turntable and antenna mast	Maturo	FCU3.0	10041
Tilt antenna mast	Maturo	TAM4.0-E	10042
Turntable 4.5 t	Maturo	TT4.0-5T	2.527
SAC	Nemko Spa	10m SAC	530
EMI receiver	Rohde & Schwarz	ESW44	101620
Common mode absorption device	Schwarzbeck	CMAD1614	00041
Antenna	Schwarzbeck	VULB9162	VULB9162-025
Shielded room	Siemens	10m control room	1947



5.1.6 Test protocol

Antenna polarization:	Horizontal
Operation mode:	1
Configuration mode:	1
Remarks:	-



Frequency (MHz)	Level (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Detector
161.2500	23.6	30.0	-6.4	QP
162.3600	24.5	30.0	-5.5	QP
168.6600	24.3	30.0	-5.7	QP



Antenna polarization: Vertical Operation mode: 1 Configuration mode: 1 Remarks: -



Frequency (MHz)	Level (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Detector
30.2400	17.6	30.0	-12.4	QP
69.3300	19.7	30.0	-10.3	QP
71.1300	20.5	30.0	-9.5	QP
112.2600	15.9	30.0	-14.1	QP
161.0700	21.9	30.0	-8.1	QP
177.9600	26.9	30.0	-3.1	QP
208.9200	19.4	30.0	-10.6	QP

Verdict: Pass

●1Pk M<u>ax</u>



5.2 Terminal disturbance voltages in the frequency range 150 kHz to 30 MHz



5.2.1 Photo documentation of the test set-up

5.2.2 Test method

Measurements were made on a ground plane that extends one meter minimum beyond all sides of the system under test. All power was connected to the system through Line Impedance Stabilization Networks (LISN). Conducted voltage measurements on mains lines were made at the output of the LISN. All tested telecommunications lines were connected to an Impedance Stabilization Network (ISN) and conducted voltage measurements on telecommunications lines were made at the output of the ISN. Where an ISN was not appropriate or available measurements were made using a Capacitive Voltage Probe and Current probe.

5.2.3 Limits for low voltage AC mains port

Frequency (MHz)	Limit (dBµV) – Quasi-Peak	Limit (dBµV) – Average
0.15 TO 0.50	66 to 56*	56 to 46*
0.50 TO 5	56	46
5 TO 30	60	50

*The limits decrease linearly with the logarithm of the frequency



5.2.4 Limits for DC mains port

Frequency (MHz)	Limit (dBµV) – Quasi-Peak	Limit (dBµV) – Average
0.15 TO 0.50	79	66
0.50 TO 30	73	60

5.2.5 Limits for telecommunication/network port

Frequency (MHz)	Limit (dBµV) – Quasi-Peak	Limit (dBµV) – Average
0.15 TO 0.50	84 to 74*	74 to 64*
0.50 TO 30	74	64

*The limits decrease linearly with the logarithm of the frequency

Frequency (MHz)	Limit (dBµA) – Quasi-Peak	Limit (dBµA) – Average
0.15 TO 0.50	40 to 30*	30 to 20*
0.50 TO 30	30	20

*The limits decrease linearly with the logarithm of the frequency

5.2.6 Test result

Verdict for AC mains port:	🛛 Р	🗌 F	🗌 N	
Verdict for DC mains port:	🗌 P	🗌 F	🛛 N	
Verdict for TLC port:	□ P	🗌 F	🛛 N	
Frequency range:	0.15 MHz	2 – 30 MHz		
Kind of test site:	Shielded	room		
Remarks:				

5.2.7 Test equipment used

Description	Manufacturer	Model	Identifier
LISN 9 kHz ÷ 30 MHz	Rohde & Schwarz	ESH2-Z5	872 460/041
EMI receiver	Rohde & Schwarz	ESU8	100202
Shielded room	Siemens	Conducted emission test room	1862



5.2.8 Test protocol

Test point:	Phase line 1
Operation mode:	1
Configuration mode:	1
Remarks:	-



Frequency (MHz)	Level (dBµV)	Limit (dBµV)	Margin (dB)	Detector
0.1780	56.6	64.6	-8.0	QP
0.1820	45.8	54.4	-8.6	Av
0.1860	55.4	64.2	-8.8	QP
0.1860	43.9	54.2	-10.3	Av
0.2340	39.0	62.3	-23.4	QP



Test point:Phase line 2Operation mode:1Configuration mode:1Remarks:-



Frequency (MHz)	Level (dBµV)	Limit (dBµV)	Margin (dB)	Detector
0.1500	52.2	66.0	-13.8	QP
0.1820	45.1	54.4	-9.2	Av
0.1860	54.2	64.2	-10.0	QP
0.1860	42.9	54.2	-11.3	Av
0.2300	38.2	62.4	-24.3	QP



Test point:Phase line 3Operation mode:1Configuration mode:1Remarks:-



Frequency (MHz)	Level (dBµV)	Limit (dBµV)	Margin (dB)	Detector
0.1740	51.8	64.8	-13.0	QP
0.1820	42.8	54.4	-11.6	Av
0.1860	52.8	64.2	-11.4	QP
0.1860	41.4	54.2	-12.9	Av
0.2340	35.5	62.3	-26.8	QP
0.2740	29.6	51.0	-21.4	Av
9.7620	26.3	60.0	-33.7	QP



5.3 Harmonics of current

5.3.1 Photo documentation of the test set-up



5.3.2 Test method according to EN 61000-3-2

This test consists on the measurement of harmonics components of the input current which may be produced by equipment having an input current up to and including 16 A per phase, and intended to be connected to public low-voltage distribution systems. The equipment is tested under specified conditions of operation.

5.4.3 Limits for low voltage AC mains port - Class A equipment

Harmonic order (n)	Maximum permissible harmonic current (A)		
	Odd harmonics		
3	2.30		
5	1.14		
7	0.77		
9	0.40		
11	0.33		
13	0.21		
15 ≤ n ≤ 40	0.15 x 15/n		
	Even harmonics		
2	1.08		
4	0.43		
6	0.30		
8 ≤ n ≤ 40	0.23 x 8/n		



5.3.5 Test result

Verdict:	
Frequency range:	0 kHz – 2 kHz
Kind of test site:	Laboratory
Class:	A
Remarks:	

5.3.6 Test equipment used

Description	Manufacturer	Model	Identifier
Mains analyzer	EMC Partner	Harmonics 1000 + HAR-EXT1000	016 + 103489



5.3.7 Test protocol

Operation mode:	1
Configuration mode:	1
Remarks:	Test Time 5 min

3ph - System [Phase L1]

Urms =	231.3V	Freq =	50.000 1 367A	Range:	50 A
P =	52.77W	S =	95.99VA	pf =	0.550
THDi =	142 %	THDu =	0.10 %	Class A	

Order	Freq.	lavg	Irms	Imax	Limit
-	[Hz]	[A]	[A]	[A]	[A]
1	50	0.2421	0.2411	0.2441	
2	100	0.0000	0.0000	0.0031	1.0800
3	150	0.0190	0.0183	0.0214	2.3000
4	200	0.0000	0.0000	0.0000	0.4300
5	250	0.2081	0.2075	0.2106	1.1400
6	300	0.0000	0.0000	0.0031	0.3000
7	350	0.1840	0.1862	0.1862	0.7700
8	400	0.0000	0.0000	0.0000	0.2300
9	450	0.0121	0.0122	0.0122	0.4000
10	500	0.0000	0.0000	0.0031	0.1840
11	550	0.1393	0.1404	0.1404	0.3300
12	600	0.0000	0.0000	0.0031	0.1533
13	650	0.1037	0.1068	0.1068	0.2100
14	700	0.0000	0.0000	0.0031	0.1314
15	750	0.0062	0.0061	0.0092	0.1500
16	800	0.0000	0.0000	0.0000	0.1150
17	850	0.0613	0.0641	0.0641	0.1324
18	900	0.0000	0.0000	0.0000	0.1022
19	950	0.0334	0.0366	0.0366	0.1184
20	1000	0.0000	0.0000	0.0000	0.0920
21	1050	0.0078	0.0092	0.0092	0.1071
22	1100	0.0000	0.0000	0.0000	0.0836
23	1150	0.0269	0.0275	0.0275	0.0978
24	1200	0.0000	0.0000	0.0000	0.0767
25	1250	0.0211	0.0214	0.0214	0.0900
26	1300	0.0000	0.0000	0.0000	0.0708
27	1350	0.0056	0.0061	0.0061	0.0833
28	1400	0.0000	0.0000	0.0000	0.0657
29	1450	0.0243	0.0244	0.0275	0.0776
30	1500	0.0000	0.0000	0.0031	0.0613
31	1550	0.0176	0.0183	0.0183	0.0726
32	1600	0.0000	0.0000	0.0000	0.0575
33	1650	0.0000	0.0031	0.0031	0.0682
34	1700	0.0000	0.0000	0.0031	0.0541
35	1750	0.0124	0.0153	0.0153	0.0643
36	1800	0.0000	0.0031	0.0031	0.0511
37	1850	0.0059	0.0061	0.0061	0.0608
38	1900	0.0000	0.0031	0.0031	0.0484
39	1950	0.0004	0.0031	0.0061	0.0577
40	2000	0.0000	0.0031	0.0031	0.0460

Verdict:

Pass



3ph - System [Phase L2]

Urms = Irms = P = THDi =	231.5V 0.391A 47.86W 153 %	Freq = lpk = S = THDu =	49.984 1.367A 90.42VA 0.20 %	Rang cf = A pf = Class	ge: 50 3.5 0.5 s A	A 00 29
	Order	Freq.	lavg	Irms	Imax	Limit
		[Hz]	[A]	[A]	[A]	[A]
	1	50	0.2137	0.2136	0.2167	
	2	100	0.0000	0.0031	0.0031	1.0800
	3	150	0.0432	0.0427	0.0458	2.3000
	4	200	0.0000	0.0031	0.0031	0.4300
	5	250	0.1822	0.1831	0.1831	1.1400
	6	300	0.0000	0.0031	0.0031	0.3000
	7	350	0.1847	0.1862	0.1862	0.7700
	8	400	0.0000	0.0031	0.0031	0.2300
	9	450	0.0362	0.0366	0.0366	0.4000
	10	500	0.0000	0.0031	0.0031	0.1840
	11	550	0.1120	0.1129	0.1129	0.3300
	12	600	0.0010	0.0031	0.0092	0.1533
	13	650	0.1155	0.1160	0.1221	0.2100
	14	700	0.0077	0.0031	0.0122	0.1314
	15	750	0.0274	0.0305	0.0305	0.1500
	16	800	0.0000	0.0031	0.0031	0.1150
	17	850	0.0404	0.0427	0.0427	0.1324
	18	900	0.0000	0.0031	0.0031	0.1022
	19	950	0.0472	0.0488	0.0488	0.1184
	20	1000	0.0000	0.0031	0.0031	0.0920
	21	1050	0.0214	0.0244	0.0244	0.1071
	22	1100	0.0000	0.0031	0.0031	0.0836
	23	1150	0.0062	0.0061	0.0092	0.0978
	24	1200	0.0000	0.0031	0.0031	0.0767
	25	1250	0.0244	0.0244	0.0244	0.0900
	26	1300	0.0000	0.0031	0.0031	0.0708
	27	1350	0.0204	0.0183	0.0244	0.0833
	28	1400	0.0002	0.0061	0.0061	0.0657
	29	1450	0.0101	0.0122	0.0122	0.0776
	30	1500	0.0033	0.0061	0.0061	0.0613
	31	1550	0.0214	0.0214	0.0244	0.0726
	32	1600	0.0000	0.0031	0.0031	0.0575
	33	1650	0.0122	0.0122	0.0153	0.0682
	34	1700	0.0001	0.0031	0.0061	0.0541
	35	1750	0.0033	0.0061	0.0061	0.0643
	36	1800	0.0012	0.0031	0.0061	0.0511
	37	1850	0.0097	0.0092	0.0122	0.0608
	38	1900	0.0030	0.0031	0.0061	0.0484
	39	1950	0.0114	0.0122	0.0122	0.0577
	40	2000	0.0059	0.0061	0.0061	0.0460



3ph - System [Phase L3]

Urms = Irms = P = THDi =	231.1V 0.366A 44.18W 151 %	Freq = lpk = S = THDu =	50.000 1.294A 84.63VA 0.20 %	Rang cf = A pf = Class	e: 50 3.5 0.5 s A	A 33 22
	Order	Freq.	lavg	Irms	Imax	Limit
		[Hz]	[A]	[A]	[A]	[A]
	1	50	0.2012	0.2014	0.2014	
	2	100	0.0000	0.0031	0.0031	1.0800
	3	150	0.0215	0.0214	0.0244	2.3000
	4	200	0.0000	0.0031	0.0031	0.4300
	5	250	0.1799	0.1801	0.1831	1.1400
	6	300	0.0000	0.0031	0.0031	0.3000
	7	350	0.1503	0.1495	0.1526	0.7700
	8	400	0.0000	0.0031	0.0031	0.2300
	9	450	0.0232	0.0244	0.0244	0.4000
	10	500	0.0000	0.0031	0.0031	0.1840
	11	550	0.1318	0.1343	0.1343	0.3300
	12	600	0.0010	0.0031	0.0092	0.1533
	13	650	0.0881	0.0885	0.0916	0.2100
	14	700	0.0075	0.0031	0.0122	0.1314
	15	750	0.0203	0.0214	0.0214	0.1500
	16	800	0.0000	0.0031	0.0031	0.1150
	17	850	0.0664	0.0671	0.0702	0.1324
	18	900	0.0000	0.0031	0.0031	0.1022
	19	950	0.0310	0.0336	0.0336	0.1184
	20	1000	0.0000	0.0031	0.0031	0.0920
	21	1050	0.0145	0.0153	0.0153	0.1071
	22	1100	0.0000	0.0031	0.0031	0.0836
	23	1150	0.0241	0.0244	0.0275	0.0978
	24	1200	0.0000	0.0031	0.0031	0.0767
	25	1250	0.0094	0.0092	0.0122	0.0900
	26	1300	0.0000	0.0031	0.0031	0.0708
	27	1350	0.0151	0.0153	0.0183	0.0833
	28	1400	0.0001	0.0061	0.0061	0.0657
	29	1450	0.0215	0.0214	0.0244	0.0776
	30	1500	0.0033	0.0061	0.0061	0.0613
	31	1550	0.0120	0.0122	0.0122	0.0726
	32	1600	0.0000	0.0031	0.0031	0.0575
	33	1650	0.0093	0.0092	0.0122	0.0682
	34	1700	0.0000	0.0031	0.0031	0.0541
	35	1750	0.0151	0.0153	0.0153	0.0643
	36	1800	0.0000	0.0031	0.0061	0.0511
	37	1850	0.0059	0.0061	0.0061	0.0608
	38	1900	0.0004	0.0031	0.0061	0.0484
	39	1950	0.0087	0.0092	0.0092	0.0577
	40	2000	0.0049	0.0061	0.0061	0.0460



5.4 Voltage changes, voltage fluctuations and flicker

5.4.1 Photo documentation of the test set-up



5.4.2 Test method according to EN 61000-3-3

This test consists on the measurement of voltage changes, voltage fluctuations and flicker which may be produced by equipment having an input current \leq 16 A per phase, and intended to be connected to public low-voltage distribution systems. The equipment is tested under specified conditions of operation.

5.4.3 Limits for low voltage AC mains port

The value of Pst shall be not greater than 1.0.

The value of Plt shall be not greater than 0.65.

The value of d(t) during a voltage change shall not exceed 3.3 % for more than 500 ms.

The relative steady-state voltage change, dc shall not exceed 3.3 %.

The maximum relative voltage change dmax shall not exceed:

- a) 4 % without additional conditions
- b) 6 % for equipment which is switched manually, or switched automatically more frequently than twice per day, and also has either a delayed restart (the delay being not less than a few tens of seconds), or manual restart, after a power supply interruption
- c) 7 % for equipment which is attended whilst in use (for example : hair dryers, vacuum cleaners, kitchen equipment such as mixers, garden equipment such as mowers, portable tools such as electric drills), or switched on automatically, or is intended to be switched on manually, no more than twice per day, and also has either a delayed restart (the delay being not less than a few tens of seconds) or manual restart, after a power supply interruption.

5.4.4 Test result

Verdict:	🛛 Р	🗌 F	□ N
Frequency:	50 Hz		
Kind of test site:	Laboratory		
Remarks:			



5.4.5 Test protocol

Operation mode:	1	Verdict:	Pass
Configuration mode:	1		
Remarks:	Test Time 10 min		
	LIN (Line Impedance Network) : L: 0.24 ohm +j0.15 ohm		
	N: 0.16 ohm +j0.10 ohm		

3ph - System [Phase L1]

	Pst	dmax	dc	dt>Lim	
Urms	= 231.3V	Freq =	50.016	Range:	50 A
Irms =	= 0.439A	lpk =	1.416A	cf =	3.222
P =	= 52.77W	S =	101.6VA	pf =	0.519

	[%]	[%]	[ms]
0.072	0.000	0.070	0.000
			1

3ph - System [Phase L2]

Urms =	231.5V	Freq =	50.016	Range:	50 A
Irms =	0.391A	lpk =	1.416A	cf =	3.625
P =	49.08W	S =	90.42VA	pf =	0.543

Pst	dmax	dc	dt>Lim
	[%]	[%]	[ms]
0.072	0.000	0.070	0.000

3ph - System [Phase L3]

= 0.508
- 3.600
e: 50 A

w v	
[%]	[ms]
0.080	0.000
	[%] 0.080

5.4.6 Test equipment used

Description	Manufacturer	Model	Identifier
Mains analyzer	EMC Partner	Harmonics 1000 + HAR-EXT1000	016 + 103489



5.5 Immunity to Power-Frequency Magnetic Fields

5.5.1 Photo documentation of the test set-up



5.5.2 Test method according to EN 61000-4-8

This test is intended to demonstrate the immunity of equipment when subjected to power frequency magnetic fields. The test magnetic field is obtained by a current flowing in an induction coil; the application of the test field to the EUT is by the immersion method.

5.5.3 Test specification

Test frequency:	50 Hz		
Continuous field intensity:	30 A/m		
Duration (Continuous field):	60 s each Axis		
Axis:	x-axis	y-axis	z-axis



5.5.4 Test result

Verdict:		
Performance Criterion:	A	
Operation mode:	1	
Configuration mode:	1	
Kind of test site:	Helmholtz coils	
Remarks: the performance criterion achieved during test was A, nothing happened during test.		

5.5.5 Test equipment used

Description	Manufacturer	Model	Identifier
Transformer 240/24 V 2.5 kVA	Eletras	220/24	2.459
Helmholtz induction coil antenna	G.I.E.	IEC 1000-4-8	111962
Field strength meter Vac	Holaday	HI-3604	86265
Induction coil antenna	Nemko	50 TURNS	
Variac	RS	WCV 8E-1	3/122017



5.6 Immunity to radio frequency electromagnetic fields

5.6.1 Photo documentation of the test set-up





5.6.2 Test method according to EN 61000-4-3

The test allows estimating of the radiated immunity of electrical and electronic equipment to electromagnetic disturbances coming from intended radio-frequency (RF) transmitters in the frequency range 80 MHz to 6000 MHz. The interference is applied on the enclosure of the equipment by using transmitting antennas. Measurements are made in a fully anechoic chamber and the indicated field strength is pre-calibrated prior to placement of the system under test.



5.6.3 Test specification

Frequency range:	80 to 1 000 MHz		1400 to 6000 MHz	
Field strength:	10 V/m ⁽¹⁾		3 V/m	
EuT - antenna separation:	2.5 m ± 0.3 m			
Modulation:	AM with 80 % in depth and 1 kHz sine wave			
Frequency step:	1 % with 3 s dwell time			
Antenna polarisation:	horizontal vertical			
Antenna position:	front rear		left	Right

5.6.4 Test result

Verdict:		
Performance Criterion:	A	
Operation mode:	1	
Configuration mode:	1	
Kind of test site:	Anechoic chamber	
Remarks: the performance criterion achieved during test was A, nothing happened during test.		

5.6.5 Test equipment used

Description	Manufacturer	Model	Identifier
Biconilog antenna (20 ÷ 6000 MHz)	ETS Lindgren	3142E	00213197
Broad-Band Horn Antenna	Schwarzbeck Mess-Elektronik	BBHA9120D	01874
RF generator (8 kHz ÷ 67 GHz)	R&S	SMA100B	104075
Broadband amplifier (80 ÷ 1000 MHz)	R&S	BBA100	101163
Broadband amplifier	R&S	BBA150	102626
Power sensor	R&S	NRP18AN	100987
Semi-anechoic chamber	Nemko	3m semi-anechoic chamber	70
Shielded room	Siemens	3m control room	3



5.7 Immunity to electrostatic discharges

5.7.1 Photo documentation of the test set-up



C = Contact Discharge / A = Air Discharge



5.7.2 Test method according to EN 61000-4-2

The test is intended to demonstrate the immunity of equipment subjected to static electricity discharges from operators directly and to adjacent objects. The table-top equipment under test is placed on a wooden table, 0.8 m high, standing on the ground reference plane. A horizontal coupling plane (HCP) is placed on the table. The EUT and the cables are isolated from the coupling plane by an insulating support 0.5 mm thick. The floor standing equipment is isolated from the ground reference plane by an insulating support about 0.1 m thick. The vertical coupling plane (VCP) of dimensions 0.5 m x 0.5 m is placed parallel to, and positioned at a distance of 0.1 m from, the EUT. Air discharges are applied to non-metallic parts of the system. Contact discharges are applied to all accessible metallic parts. Discharges are also applied to the Horizontal and Vertical Coupling Planes.

5.7.3 Test specification

Contact discharge voltage:	4 kV		
Air discharge voltage:	8 kV		
Discharge impedance:	330 Ω / 150 pF		
Time between successive discharges:	≥ 1 s		
Number of discharges:	≥ 10		
Type of direct discharge:	air discharge contact discharge		
Type of indirect discharge:	contact discharge		
Polarity:	positive	negative	

5.7.4 Test result

Discharge location	Type of discharge
Horizontal coupling plane (HCP)	Contact
Vertical coupling plane (VCP)	Contact
Metallic parts of the enclosure	Contact
Enclosure – plastic parts	Air

Verdict:	🛛 Р	🗌 F	□ N
Performance Criterion:	В		
Operation mode:	1		
Configuration mode:	1		
Kind of test site:	Laboratory		
Remarks: the performance criterion achieved during test was A, nothing happened during test.			

5.7.5 Test equipment used

Description	Manufacturer	Model	Identifier
ESD Test system	EMC Partner	ESD3000	252



5.8 Immunity to injected currents up to 80 MHz

5.8.1 Photo documentation of the test set-up



5.8.2 Test method according to EN 61000-4-6

The test allows estimating of the conducted immunity of electrical and electronic equipment to electromagnetic disturbances coming from intended radio-frequency (RF) transmitters in the frequency range 150 kHz to 80 MHz. The interference is applied on mains supply, signal line and earth connection ports by using coupling decoupling networks or a clamp. Measurements are made on a ground plane. The EUT was located 10cm above the reference ground plane and any associated I/O cables attached to the EUT are located between 30mm and 50mm above the ground plane. The indicated field is pre-calibrated prior to placement of the system under test.

5.8.3 Test specification

Frequency range:	0.15 MHz to 80 MHz
Test voltage:	10 V ⁽¹⁾
Modulation:	AM with 80 % in depth and 1 kHz sine wave
Frequency step:	1 % with 3 s dwell time



5.8.4 Test result

Coupling point	Coupling and decoupling devices	Verdict
AC mains	M4	Р
DC power ports	M2	N
Signal	Clamp	N

Verdict:		
Performance Criterion:	A	
Operation mode:	1	
Configuration mode:	1	
Kind of test site:	Laboratory	
Remarks: the performance criterion achieved during test was A, nothing happened during test.		

5.8.5 Test equipment used

Description	Manufacturer	Model	Identifier
Attenuator 6dB	EM Test	ATT6/75	0206-18
Coupling/decoupling network	EM Test	CDN M4 PE 32A	P1428136828
Shielded room	Siemens	Conducted immunity test room	68
Test system for conducted and radiated immunty	Teseq + Ametek	NSG4070C-80	540126



5.9 Immunity to fast transients/bursts

5.9.1 Photo documentation of the test set-up







5.9.2 Test method according to EN 61000-4-4

The test is intended to demonstrate the immunity of equipment subjected to types of transient disturbances such as those originating from switching transients (interruption of inductive loads, relay contact bounce...). The bursts are applied on the mains supply port by using a coupling decoupling network and on signal and control lines ports by using a capacitive clamp. Measurements are made on a ground plane.



5.9.3 Test specification

Voltage level for I/O AC power ports:	2 kV	
Voltage level for I/O DC power ports:	2 kV	
Voltage level for signal ports:	1 kV	
Burst frequency:	5.0 kHz	
Coupling duration:	≥ 60 s	
Polarity:	positive	negative

5.9.4 Test result

Coupling point	Level	Coupling devices	Verdict
AC mains	4 kV1	Network	Р
DC power port	2 kV	Network	Р
Signal	2 kV1	Clamp	Р

Verdict:			
Performance Criterion:	В		
Operation mode:	1		
Configuration mode:	1		
Kind of test site:	Laboratory		
Remarks: ¹ levels requested by the applicant the performance criterion achieved during test.			

5.9.5 Test equipment used

Description	Manufacturer	Model	Identifier
Coupling clamp	EMC partner	CDN	CNEFT1000-120
Coupling/Decoupling network	EMC partner	CDN2000-06-32	1537
Pulse generator	EMC partner	IMU3000	F5-S-D-V-1505



5.10 Immunity to surges

5.10.1 Photo documentation of the test set-up



5.10.2 Test method according to EN 61000-4-5

The test allows estimating of the conducted immunity of electrical and electronic equipment to unidirectional surges caused by over voltages from switching and lighting transients. The interference is applied on symmetrical and unsymmetrical modes on mains supply port by using coupling decoupling network. Five positive surges and five negative surges are applied at each of phases of the a.c. waveform: 0°, 90°, 180° and 270°. Each surge was applied 60 seconds after the previous surge. Signal and Telecommunications ports were subject to five positive and five negative surges applied through the appropriate Coupling/Decoupling Network (CDN).



5.10.3 Test specification for AC power ports

Pulse amplitude for line to line surge:	1 kV with a source impedance of 2 Ω + 18 μF			
Pulse amplitude for line to earth surge:	2 kV with a source impedance of 12 Ω + 9 μF			
Number of surges:	5 Surges/Phase angle			
Phase angle:	0°	90°	180°	270°
Repetition rate:	60 s			
Rise time:	1.2 μs			
Time to half value:	50 μs			
Polarity:	positive negative			

5.10.4 Test specification for DC power ports

Pulse amplitude for line to line surge:	0.5 kV with a source impedance of 2 Ω + 18 μF		
Pulse amplitude for line to earth surge:	0.5 kV with a source impedance of 12 Ω + 9 μ F		
Number of surges:	5 Surges/Polarity		
Repetition rate:	60 s		
Rise time:	1.2 μs		
Time to half value:	50 μs		
Polarity:	positive	negative	



5.10.5 Test specification for signal ports

Pulse amplitude for line to earth surge:	1 kV with a source impedance of 42 Ω + 0.5 μF		
Pulse amplitude for shield to earth surge:	1 kV (direct on the shield)		
Number of surges:	5 Surges/Polarity		
Repetition rate:	60 s		
Rise time:	1.2 µs		
Time to half value:	50 μs		
Polarity:	positive negative		

5.10.6 Test result

Coupling point	Level	Coupling network	Verdict
AC mains – line to line	2 kV1	2 Ω + 18 μF	Р
AC mains – line to earth	4 kV1	12 Ω + 9 μF	Р
DC power port – line to line	0.5 kV	2 Ω + 18 μF	Р
DC power port – line to earth	1 kV1	12 Ω + 9 μF	Р
Signal ports	1 kV	42 Ω + 0.5 μF	N
Signal ports	1 kV	direct	N

Verdict:				
Performance Criterion:	В			
Operation mode:	1			
Configuration mode:	1			
Kind of test site:	Laboratory			
Remarks: ¹ levels requested by the applicant The performance criterion achieved during test was A, nothing happened during test.				

5.10.7 Test equipment used

Description	Manufacturer	Model	Identifier
Coupling/Decoupling network	EMC partner	CDN2000-06-32	1537
Pulse generator	EMC partner	IMU3000	F5-S-D-V-1505



5.11 Immunity to voltage dips and interruptions

5.11.1 Photo documentation of the test set-up



5.11.2 Test method according to EN 61000-4-11 - EN 61000-4-34

The test allows estimating of the conducted immunity of electrical and electronic equipment connected to low-voltage power supply networks for voltage dips and short interruptions. Testing is performed with the product connected directly to a generator capable of simulating the voltage drops and interrupts as described.

5.11.3 Test specification

Nominal Mains Voltage	400 Vac
Rated frequency	50 Hz
Number of voltage dips and interruptions	3
Sync Angle	0°



5.11.4 Test result

	Level of reduction	Residual voltage	Duration	Performance criterion	Verdict
1	100%	0%	1 cycle	B ¹	Р
2	60%	40%	200 ms	C ¹	Р
3	30%	70%	500 ms	C ¹	Р
4	100%	0%	5 s	C ²	Р

Verdict:	🛛 P	🗌 F	□ N
Operation mode:	1		
Configuration mode:	1		
Kind of test site:	Laboratory		
Remarks:	•		

¹ The performance criterion achieved during test was A, nothing happened during test. ² During the test, the EUT stop with self-recovering of the normal working after the test.

5.11.5 Test equipment used

Description	Manufacturer	Model	Identifier
Coupling/Decoupling network	EMC partner	CDN2000-06-32	1537
Pulse generator	EMC partner	IMU3000	F5-S-D-V-1505



6 EUT PHOTOS







End of report